

2016 Mass Resolution Re-Evaluation

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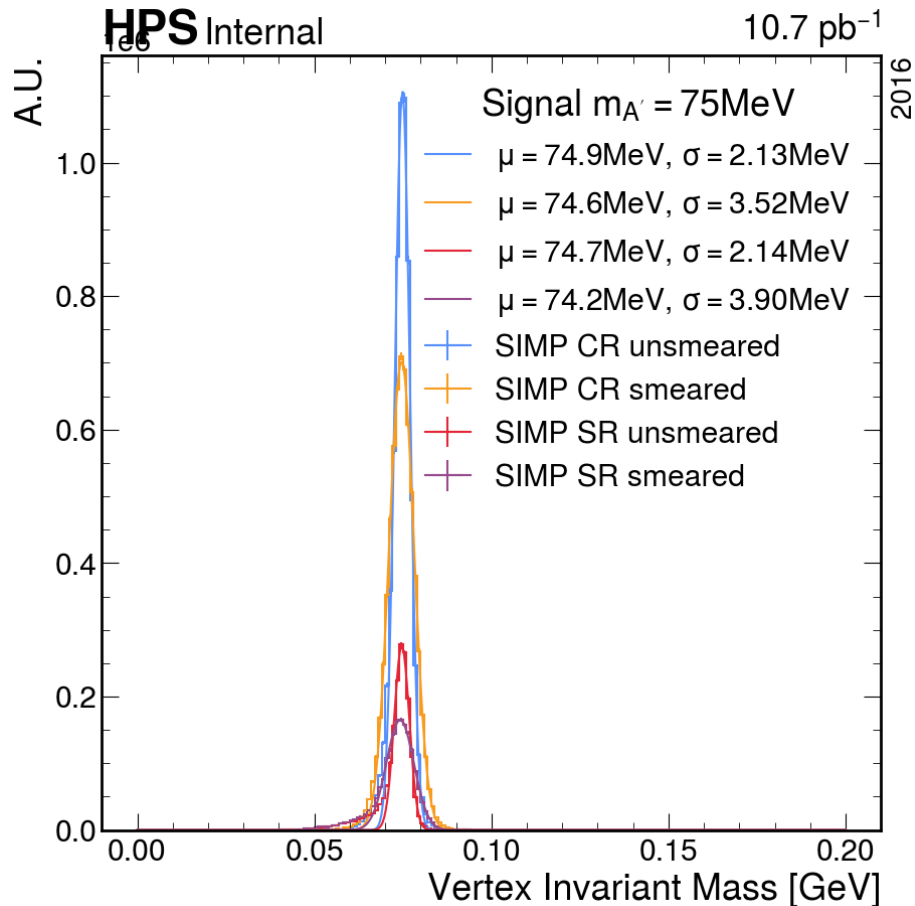
April 2, 2024

Re-Evaluate 2016 Mass Resolution

Due to a variety of simulation and reconstruction patches and updates.

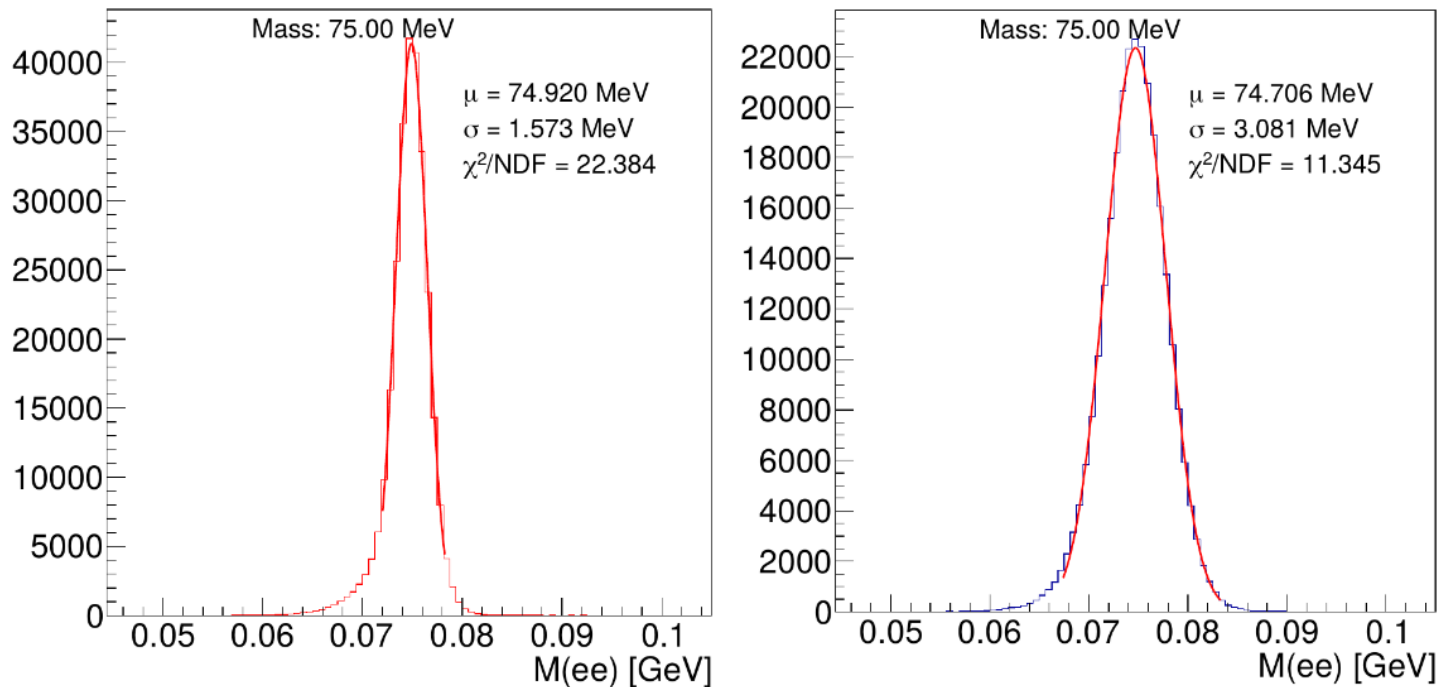
- Signal samples generated and reconstructed by Cam
 - ▶ Added to sample list for Pass4b on confluence ▶ `pass4b for 2016 MC`
- Applied momentum smearing with hpstr
 - ▶ Code in ▶ `hpstr PR 187`
- Plotted and fit in notebook
 - ▶ Selecting vertices whose tracks have been strictly matched to truth-level “rad” electrons (i.e. not contaminated with recoil electrons)

More Similar Selection



- Reduction in low-side tail distorting results
- Resulting resolution σ still deviating more from previous estimate, but at a much smaller scale

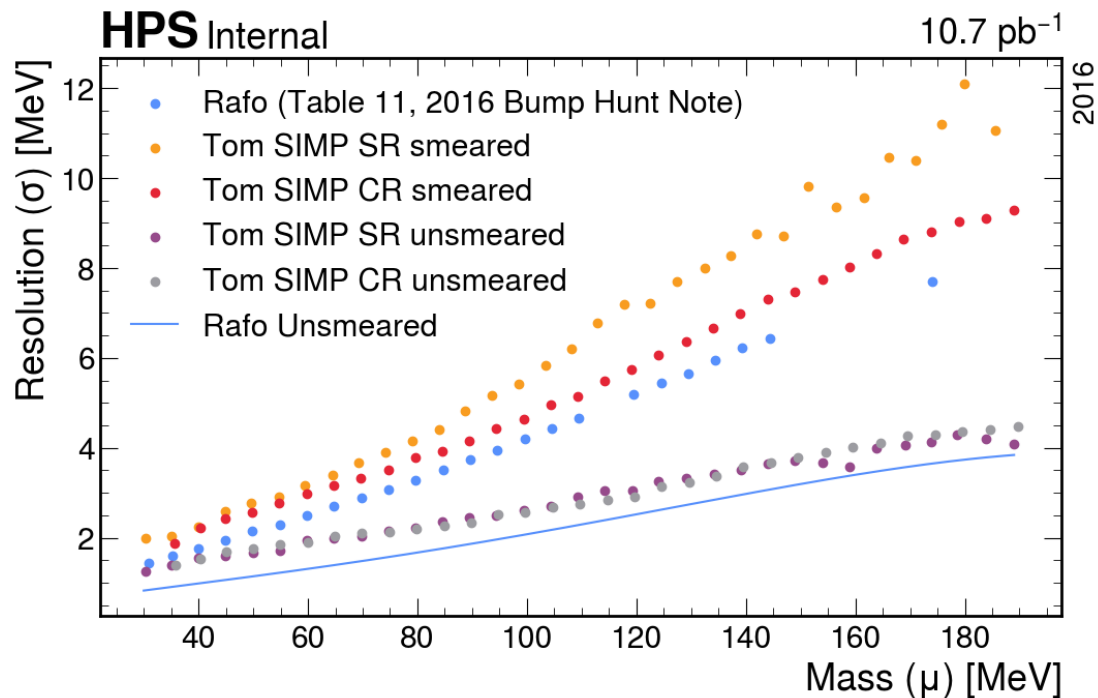
For Comparison



Looks like fit is restricted to mass peak (which makes sense and is something I am also doing)

Figure 28: Mass distribution for 75 MeV A' MC. Left: unsmeared mass, right: smeared mass

Figure: From Rafo's 2016 Bump Hunt Internal Note end of Section 4.



- Able to use newer generated samples to produce mass resolution estimates including track smearing
- Observing slight worsening in resolution (increase in σ) compared to previous estimate

Questions

How I evaluated the resolution



Goal : Center (mean μ) and Width (std dev σ) of peak

Two stage process

1. Find Peak

Iterative approach

1. Calculate μ and σ from the bins
2. Remove bins further than $N\sigma$ away from μ
3. Repeat until stable (i.e. no bins are being removed)

For the results here, I chose $N = 2$.

2. Fit Normal Distribution

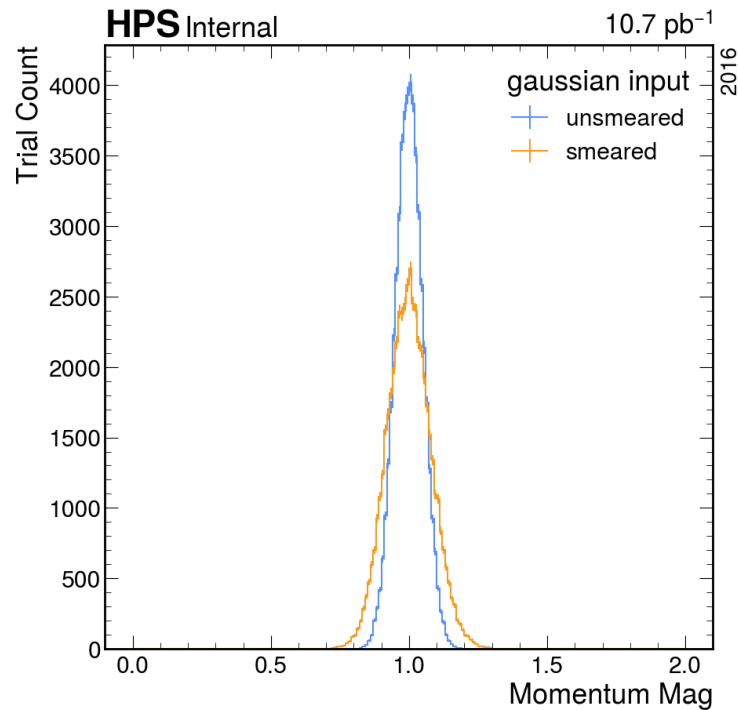
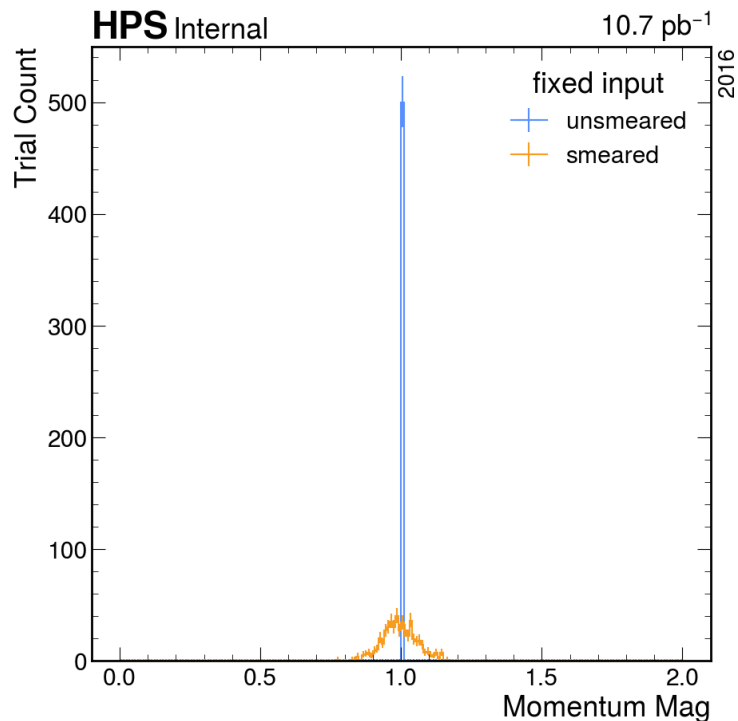
- Actually fitting a “scaled” normal distribution which is just a normal distribution multiplied by some scale (basically ends up being the integral of the fit range if fit is good).
- Only fitting to the range of bins selected in Stage 1 above.
- Using uncertainty on bin content as errors of data points in fit.
- μ and σ taken from this fit.

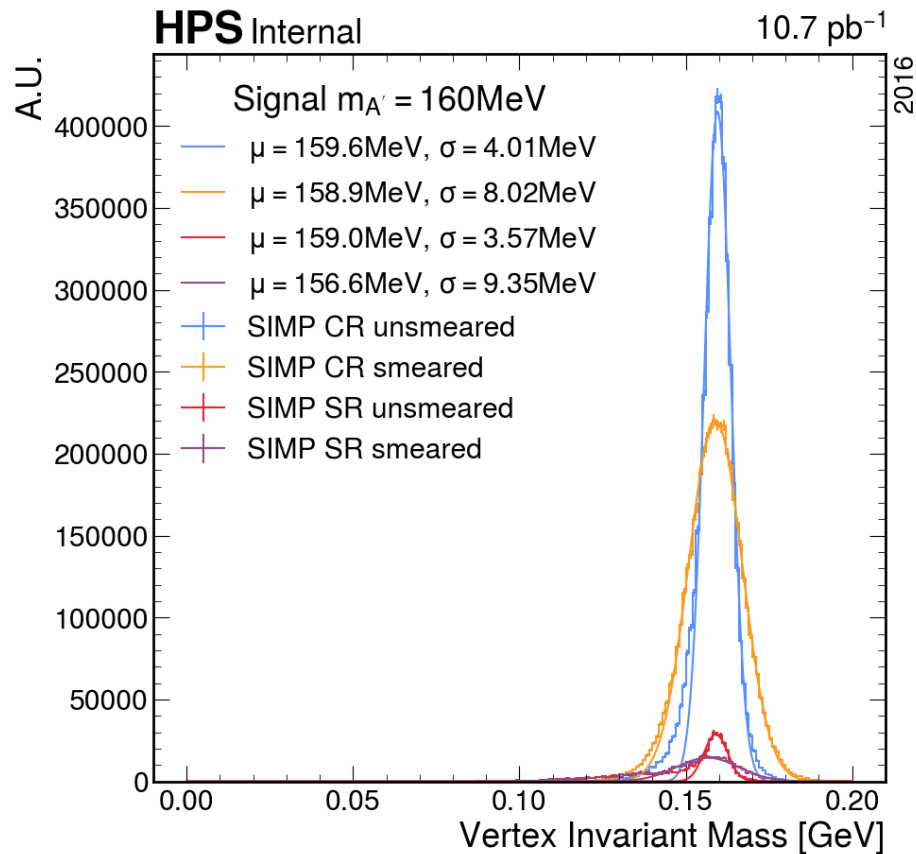
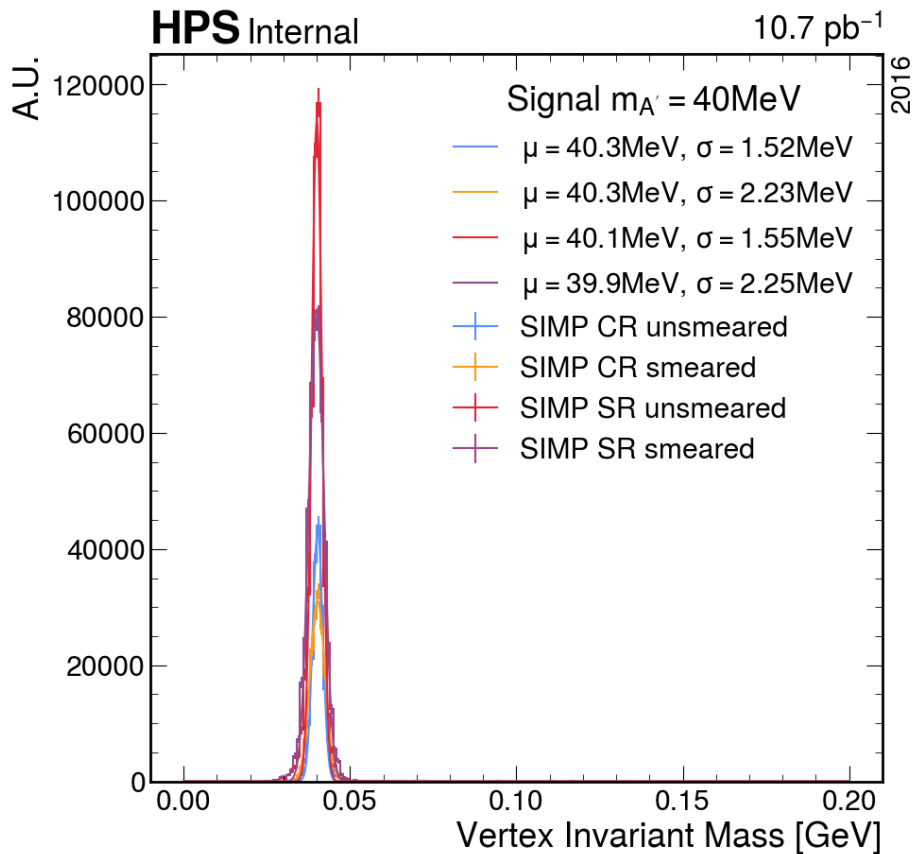
Direct Testing of Smearing Tool



Manually constructing tracks with known input momenta and then applying smearing.

✓ Get expected results ✓





Selection Comparison

Not thoroughly checked!!



SIMP CR

1. L1 Requirement
2. $P_{\text{sum}} > 1.9 \text{ GeV}$
3. Electron matched to truth rad electron
4. Single Vertex Candidate

SIMP SR

1. L1 Requirement
2. $P_{\text{sum}} < 1.9 \text{ GeV}$
3. $P_{\text{sum}} > 1.0 \text{ GeV}$
4. Electron matched to truth rad electron
5. Single Vertex Candidate

Rafo Tables 4 and 7

1. Preselection

- ▶ $\chi^2 < 12$, Goodness of PID < 10 , cluster-track time diff $< 6 \text{ ns}$ for both tracks
- ▶ Electron track has $P < 2.15 \text{ GeV}$

2. $P_{\text{sum}} < 2.4 \text{ GeV}$

3. $P_{\text{sum}} > 1.9 \text{ GeV}$

4. $|\Delta t_{\text{cluster}}| < 1.43 \text{ ns}$

5. Single Vertex Candidate